advanced high voltage MOSFET process that is designed to deliver high levels of performance and robustness in popular AC-DC applications. By providing low R _{Spin} , C _{fiss} and C _{ress} along with guaranteed avalanche capability this part can be adopted quickly into new and existing offline power supply designs. For Halogen Free add "L" suffix to part number: AOTF10N50FDL Top View TO-220F Top View TO-220F AOTF10N50FDL ADTF10N50FDL Top View TO-220F Composition of the set of	ALPHA & OMEGA SEMICONDUCTOR 500V, 10A N-Channel MOSFET with Fast Recovery Diode										
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$\begin{tabular}{ c c c c c c } \hline V_{C20F} & J_{C}^{D}	For Halogen Free add "L" suffix to part number:				RoHS						
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$\begin{array}{c c c c c c c } \hline Current & T_{C}=100^{\circ}C & I_{D} & 6^{*} & A \\ \hline Pulsed Drain Current ^{C} & I_{DM} & 33 & A \\ \hline Pulsed Drain Current ^{C} & I_{AR} & 3.8 & A \\ \hline Repetitive avalanche energy ^{C} & E_{AR} & 216 & mJ \\ \hline Single pulsed avalanche energy ^{G} & E_{AS} & 433 & mJ \\ \hline Peak diode recovery dv/dt & dv/dt & 5 & V/ns \\ \hline Power Dissipation ^{B} & T_{C}=25^{\circ}C & P_{D} & 50 & W \\ \hline Derate above 25^{\circ}C & P_{D} & 0.4 & W/ ^{\circ}C \\ \hline Junction and Storage Temperature Range & T_{J}, T_{STG} & -55 to 150 & ^{\circ}C \\ \hline Maximum lead temperature for soldering \\ purpose, 1/8" from case for 5 seconds & T_{L} & 300 & ^{\circ}C \\ \hline \ Parameter & Symbol & AOT10N50FD & Units \\ \hline \end{array}$		T -25°C	V _{GS}		V						
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Current	T _C =100°C	— I _D		A						
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Power Dissipation B Derate above 25°C PD 0.4 W/ °C Junction and Storage Temperature Range TJ, TSTG -55 to 150 °C Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds TL 300 °C Thermal Characteristics Parameter Symbol AOT10N50FD Units											
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					•						
			Symbol	AOT10N50FD	Units						
Maximum Junction-to-Ambient ^{A,D} R _{0JA} 65 °C/W			R _{0JA}	65	°C/W						
Maximum Junction-to-Case R _{0JC} 2.5 °C/W	Maximum Junction-to-Case			2.5	°C/W						

* Drain current limited by maximum junction temperature.



Electrical Characteristics (TJ=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Мах	Units	
STATIC	PARAMETERS						
		I _D =10mA, V _{GS} =0V, T _J =25°C	500				
BV _{DSS} Drain-Source Breakdown Voltage		I _D =10mA, V _{GS} =0V, T _J =150°C		600		V	
BV _{DSS} /∆TJ	Breakdown Voltage Temperature Coefficient	I _D =10mA, V _{GS} =0V		0.56		V/°C	
I _{DSS} Z	Zero Gate Voltage Drain Current	V _{DS} =500V, V _{GS} =0V			10		
		V _{DS} =400V, T _J =125°C			100	μA	
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±30V			±100	nA	
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =5V, Ι _D =250μΑ	2.5	3.1	4.2	V	
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =5A		0.6	0.75	Ω	
g _{FS}	Forward Transconductance	V _{DS} =40V, I _D =5A		10		S	
V _{SD}	Diode Forward Voltage	I _S =10A,V _{GS} =0V		0.93	1.6	V	
I _S	Maximum Body-Diode Continuous Current				10	Α	
I _{SM}	Maximum Body-Diode Pulsed Current				33	Α	
DYNAMI	C PARAMETERS						
C _{iss}	Input Capacitance		820	1030	1240	pF	
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =25V, f=1MHz	75	112	150	pF	
C _{rss}	Reverse Transfer Capacitance		5	10	15	pF	
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz	1.7	3.4	5.2	Ω	
SWITCH	ING PARAMETERS				-		
Q _g	Total Gate Charge		20	26	35	nC	
Q_{gs}	Gate Source Charge	V_{GS} =10V, V_{DS} =400V, I_{D} =10A		4.8		nC	
Q_{gd}	Gate Drain Charge			9.5		nC	
t _{D(on)}	Turn-On DelayTime			24		ns	
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =250V, I_{D} =10A,		65		ns	
t _{D(off)}	Turn-Off DelayTime	$R_G=25\Omega$		69		ns	
t _f	Turn-Off Fall Time			50		ns	
t _{rr}	Body Diode Reverse Recovery Time	I _F =10A,dI/dt=100A/μs,V _{DS} =100V		116	190	ns	
Q _{rr}	Body Diode Reverse Recovery Charg	e I _F =10A,dI/dt=100A/µs,V _{DS} =100V		0.3	0.6	μC	

A. The value of R $_{\rm \theta JA}$ is measured with the device in a still air environment with T $_{\rm A}$ =25°C.

B. The power dissipation P_D is based on $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$ =150°C, Ratings are based on low frequency and duty cycles to keep initial T_J =25°C.

D. The R $_{\rm 0JA}$ is the sum of the thermal impedance from junction to case R $_{\rm 0JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μ s pulses, duty cycle 0.5% max.

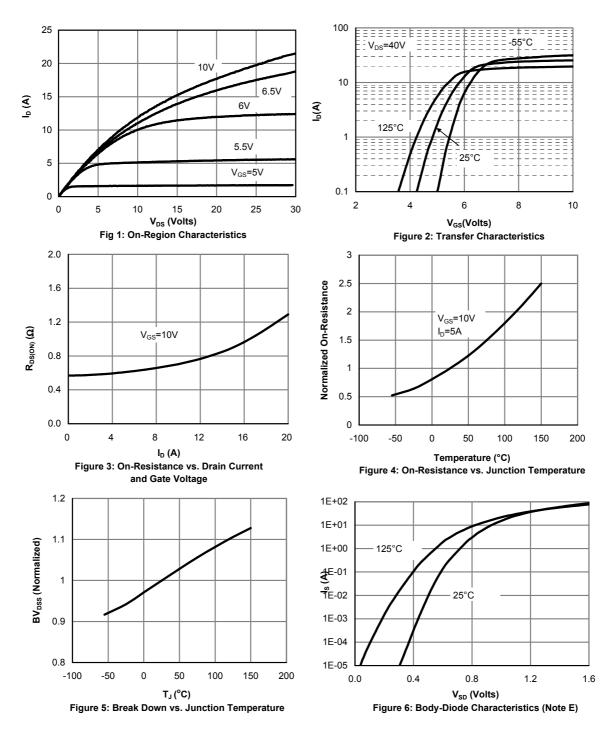
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =150°C. The SOA curve provides a single pulse rating.

G. L=60mH, I_{AS}=3.8A, V_{DD}=150V, R_G=25 Ω , Starting T_J=25°C

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

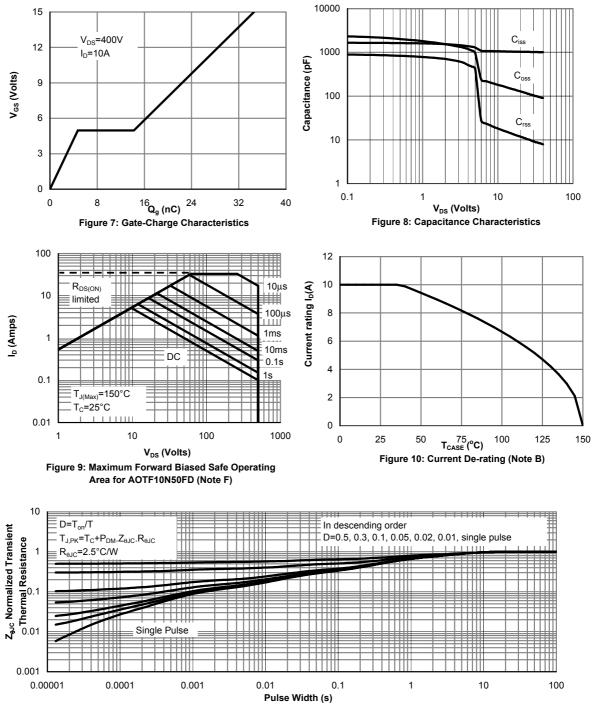
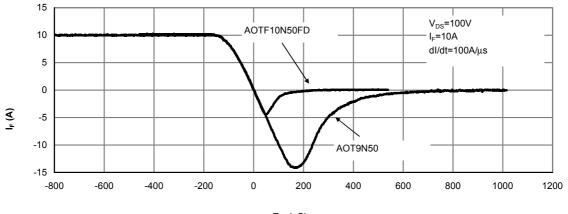


Figure 11: Normalized Maximum Transient Thermal Impedance for AOTF10N50FD (Note F)



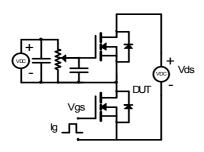
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

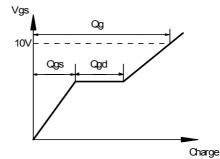


Trr (nS) Figure 12: Diode Recovery Characteristics

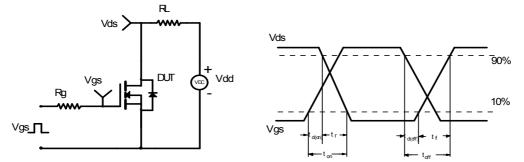


Gate Charge Test Circuit & Waveform

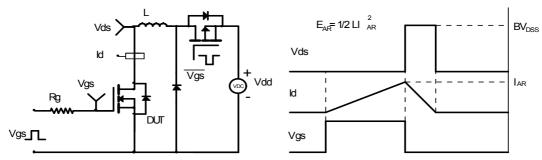




Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

